Power MOSFET

30 V, 12.3 A, Single N-Channel, SO-8

Features

- Low R_{DS(on)}
- Low Gate Charge
- Standard SO-8 Single Package
- Pb-Free Package is Available

Applications

- Notebooks, Graphics Cards
- Synchronous Rectification
- High Side Switch
- DC-DC Converters

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

| Parameter | | | Symbol | Value | Unit |
|---|---------------------------------------|-----------------------|--------------------------------------|---------------|------|
| Drain-to-Source Voltage | | | V _{DSS} | 30 | V |
| Gate-to-Source Voltage | | | V _{GS} | ±20 | V |
| Continuous Drain | Steady | T _A = 25°C | -I _D | 10 | А |
| Current (Note 1) | State | T _A = 85°C | | 7.3 | |
| | $t \le 10 s$ | T _A = 25°C | | 12.3 | |
| Power Dissipation (Note 1) | Steady State T _A = 25°C | | PD | 1.6 | W |
| | $t \le 10 s$ | | | 2.3 | |
| Continuous Drain | Steady | T _A = 25°C | I _D | 7.6 | A |
| Current (Note 2) | State | T _A = 85°C | | 5.4 | |
| Power Dissipation (Note 2) | | T _A = 25°C | PD | 0.86 | W |
| Pulsed Drain Current | t _p = | i 10 μs | IDM | 37 | A |
| Operating Junction and Storage Temperature | | | T _J , T _{stg} | –55 to 150 | °C |
| Source Current (Body Diode) | | | ls | 2.3 | А |
| Single Pulse Drain-to-Source Avalanche Energy (V _{DD} = 25 V, V _{GS} = 10 V, I _L Peak = 7.5 A, L = 10 mH, R _G = 25 Ω) | | | E _{AS} | 200 | mJ |
| Lead Temperature for Soldering Purposes (1/8" from case for 10 secs) | | | ΤL | 260 | °C |

THERMAL RESISTANCE MAXIMUM RATINGS

| Parameter | Symbol | Value | Unit |
|--|-----------------|-------|------|
| Junction-to-Ambient - Steady State (Note 1) | R_{\thetaJA} | 80.5 | °C/W |
| Junction-to-Ambient – t \leq 10 s (Note 1) | $R_{\theta JA}$ | 55 | |
| Junction-to-Ambient - Steady State (Note 2) | $R_{\theta JA}$ | 145 | |

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Surfacemounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).

2. Surfacemounted on FR4 board using the minimum recommended pad size.

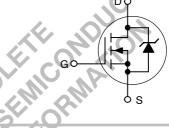


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| | V _{(BR)DSS} | R _{DS(ON)} TYP | I _D MAX | |
|---|----------------------|-------------------------|--------------------|--|
| - | 30 V | 7.5 mΩ @ 10 V | 12.3 A | |
| • | 30 V | 10 mΩ @ 4.5 V | 12.3 A | |
| Ĵ | | | | |





MARKING DIAGRAM/ **PIN ASSIGNMENT**

4704N ALYW

Top View

Drain

⊐ Drain

🛥 Drain

🛥 Drain



CASE 751 STYLE 12

А

1

Y

4704N = Device Code

Source 😐

Source 🞞

Source 📼

Gate =

- = Assembly Location
- = WaferLot
- = Year ww
 - = Work Week
 - = Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

| Device | Package | Shipping [†] |
|--------------|-------------------|-----------------------|
| NTMS4704NR2 | SO-8 | 2500/Tape & Reel |
| NTMS4704NR2G | SO-8 (Pb-Free) | 2500/Tape & Reel |

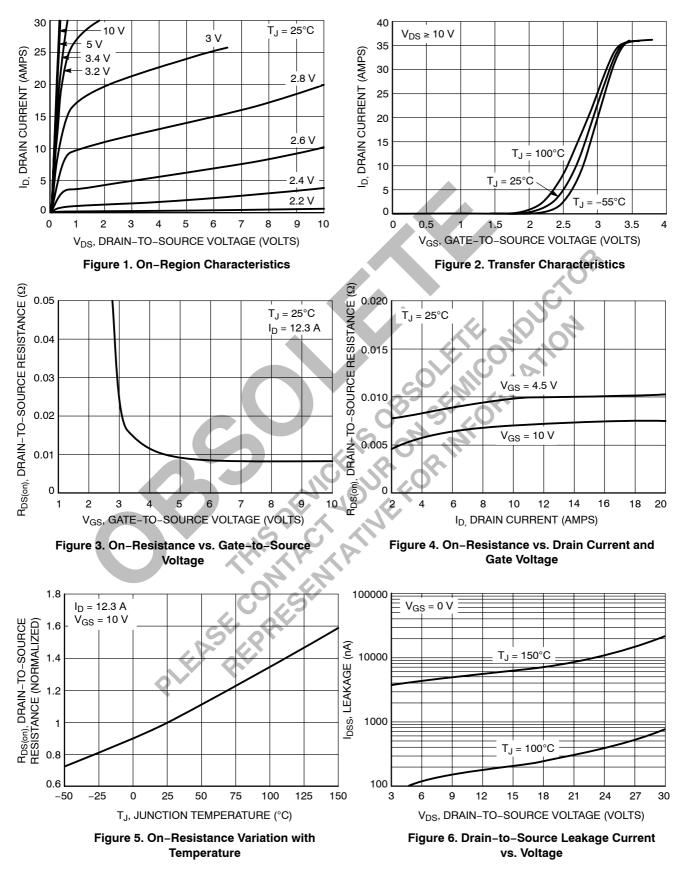
†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

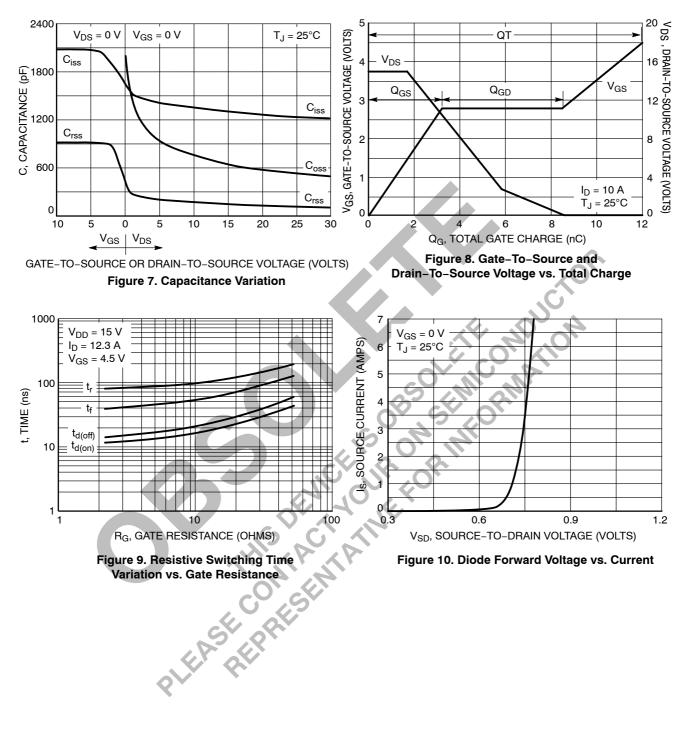
| Parameter | Symbol | Test Condition | | Min | Тур | Max | Unit |
|--|--------------------------------------|--|------------------------|-----|------------|------|-------|
| OFF CHARACTERISTICS | - | - | | | - | - | - |
| Drain-to-Source Breakdown Voltage | V _{(BR)DSS} | V_{GS} = 0 V, I _D = 250 μ A | | 30 | | | V |
| Drain-to-Source Breakdown Voltage Temperature Coefficient | V _{(BR)DSS} /T _J | | | | 28 | | mV/°C |
| Zero Gate Voltage Drain Current | I _{DSS} | | $T_J = 25^{\circ}C$ | | | 1.0 | μΑ |
| | | V_{GS} = 0 V, V_{DS} = 24 V | T _J = 125°C | | | 50 | |
| Gate-to-Source Leakage Current | I _{GSS} | V_{DS} = 0 V, V_{GS} = | ±20 V | | | ±100 | nA |
| ON CHARACTERISTICS (Note 3) | | | | | | | |
| Gate Threshold Voltage | V _{GS(TH)} | $V_{GS} = V_{DS}, I_D = 2$ | 250 μΑ | 1.0 | | 2.5 | V |
| Negative Threshold Temperature Coefficient | V _{GS(TH)} /T _J | | | | 5.0 | | mV/°C |
| Drain-to-Source On Resistance | R _{DS(on)} | V _{GS} = 10 V, I _D = 1 | 12.3 A | | 7.5 | 9.5 | mΩ |
| | | V _{GS} = 4.5 V, I _D = | 10 A | | 10 | 12.5 | |
| Forward Transconductance | 9 FS | V _{DS} = 15 V, I _D = 10 A | | | 20 | | S |
| CHARGES, CAPACITANCES AND GATE F | RESISTANCE | | | | <u>S</u> . | | • |
| Input Capacitance | C _{iss} | | | | 1225 | | pF |
| Output Capacitance | C _{oss} | V _{GS} = 0 V, f = 1.0 MHz, | V _{DS} = 20 V | 0 | 580 | | |
| Reverse Transfer Capacitance | C _{rss} | | | | 125 | | |
| Total Gate Charge | Q _{G(TOT)} | V _{GS} = 4.5 V, V _{DS} = 15 V, I _D = 10 A | | | 12 | 17 | nC |
| Threshold Gate Charge | Q _{G(TH)} | | | | 1.6 | | |
| Gate-to-Source Charge | Q _{GS} | | | | 3.25 | | |
| Gate-to-Drain Charge | Q _{GD} | | | | 5.25 | | |
| Gate Resistance | R _G | | | | 1.8 | | Ω |
| SWITCHING CHARACTERISTICS (Note 4) | | 7.0.8 | | | | | |
| Turn-On Delay Time | t _{d(on)} | | | | 8.2 | | ns |
| Rise Time | tr | V _{GS} = 10 V, V _{DD} = 15 V | /. I₀ = 1.0 A. | | 5.4 | | 1 |
| Turn–Off Delay Time | t _{d(off)} | $R_{\rm G} = 3.0 \Omega$ | | | 28.4 | | 1 |
| Fall Time | ty | | | | 10.5 | | 1 |
| DRAIN-SOURCE DIODE CHARACTERIST | | | | | | | |
| Forward Diode Voltage | V _{SD} | | $T_J = 25^{\circ}C$ | | 0.75 | 1.0 | V |
| S | | V_{GS} = 0 V, I _S = 2.3 A | T _J = 125°C | | 0.56 | | 1 |
| Reverse Recovery Time | t _{RR} | | | | 35 | | ns |
| Charge Time | t _a | V_{GS} = 0 V, d_{IS}/d_t = 100 A/µs, I_S = 2.3 A | | | 18 | | 1 |
| Discharge Time | t _b | | | | 17 | | 1 |
| Reverse Recovery Charge | Q _{RR} | | | | 33 | | nC |

Pulse Test: pulse width = 300 μs, duty cycle ≤ 2%.
Switching characteristics are independent of operating junction temperatures.

TYPICAL PERFORMANCE CURVES

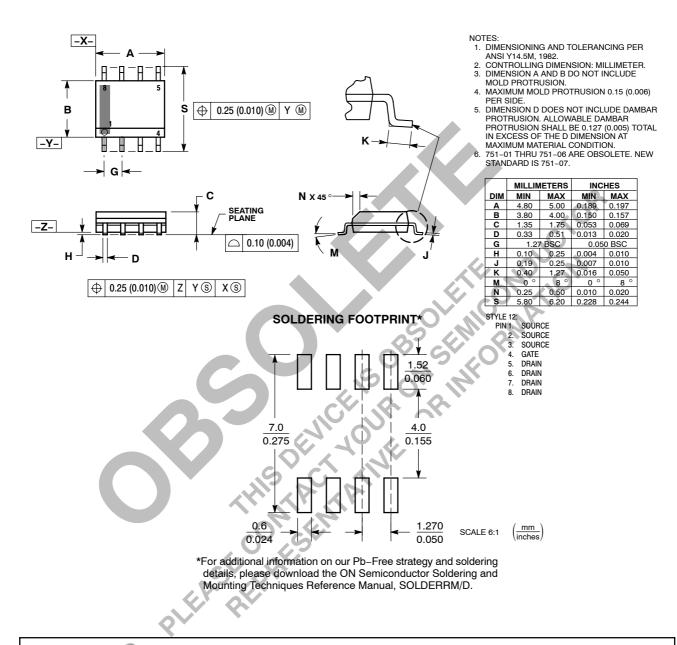


TYPICAL PERFORMANCE CURVES



PACKAGE DIMENSIONS

SOIC-8 CASE 751-07 ISSUE AG



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